

<b>INFORMATION DISCLOSURE CITATION</b>  <b>PTO-1449</b>			ATTY. DOCKET NO. 23444-712		SERIAL NO. 09/614,224		
			APPLICANT Thomas B. Mason et al.				
			FILING DATE 7/12/2000		GROUP <del>2874</del> 2828		
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE	
lj	5,088,105	2/11/92	Scifres et al.	372	92	/	
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<b>FOREIGN PATENT DOCUMENTS</b>							
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						YES	NO
lj	0 620 475 A1	3/14/94	Europe	G02F	1/313	<input checked="" type="checkbox"/>	<input type="checkbox"/>
lj	1 539 028	1/24/79	Europe	Ho1S	3/02	<input checked="" type="checkbox"/>	<input type="checkbox"/>
<b>OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)</b>							
lj	Bar-Chaim, N. et al., "Monolithic Optoelectronic Integration of a GaAlAs Laser, a Field-Effect Transistor, and a Photodiode", <i>Applied Physics Letters, US, American Institute of Physics</i> , May 15, 1984, Vol. 44, No. 10, pp. 941-943						
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	San-Liang, L. et al., "Sampled Grating DBR Laser Arrays with Adjustable 0.8/1.6-nm Wavelength Spacing", <i>IEEE Photonics Technology Letters</i> , August 1999, Vol. 11, No. 8, pp. 955-957						
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EXAMINER <i>Jeffrey Zahn</i>			DATE CONSIDERED <i>9/26/02</i>				

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.